Supporting Information (3 pages)

Effect of Fractal Silver Electrodes on Charge Collection and Light Distribution in Semiconducting Organic Polymer Films

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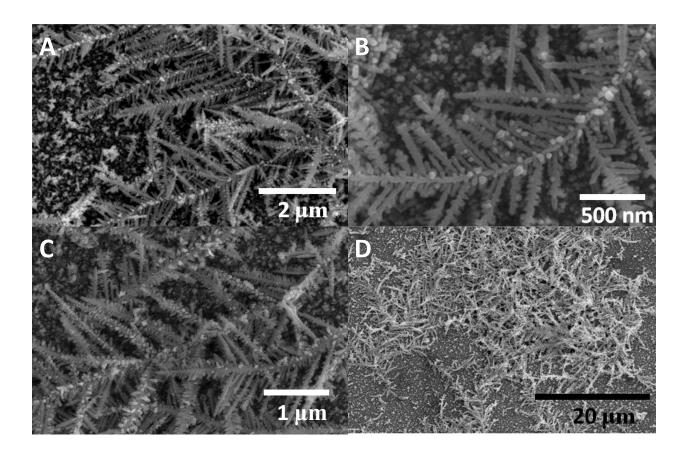


Figure S1. Scanning electron microscopy images of fractal silver on FTO obtained by electrodeposition at -0.85 V vs NHE for 300 s from an aqueous solution of $0.005 \text{ M Ag}_2\text{SO}_4$, $0.01 \text{ M H}_2\text{SO}_4$, and $0.5 \text{ M Na}_2\text{SO}_4$.

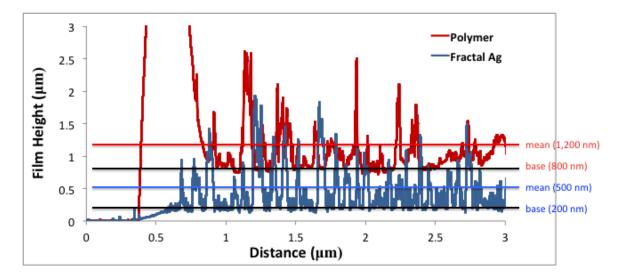


Figure S2. Representative profilometer traces for non-coated and polymer coated silver fractal films. Polymer thickness (600 nm) was calculated by subtracting the baseline of the fractal silver (200 nm) from the baseline of the polymer-coated film (800 nm). Mean fractal heights are also shown.